



64K x 16 Static RAM

Features

- **High speed**
— $t_{AA} = 9, 10, 12, 15, 20 \text{ ns}$
- **CMOS for optimum speed/power**
- **Low active power**
— 965 mW (max.)
- **Automatic power-down when deselected**
- **Independent control of upper and lower bits**
- **Available in 44-pin TSOP II and 400-mil SOJ**

Functional Description

The CY7C1021B is a high-performance CMOS static RAM organized as 65,536 words by 16 bits. This device has an automatic power-down feature that significantly reduces power consumption when deselected.

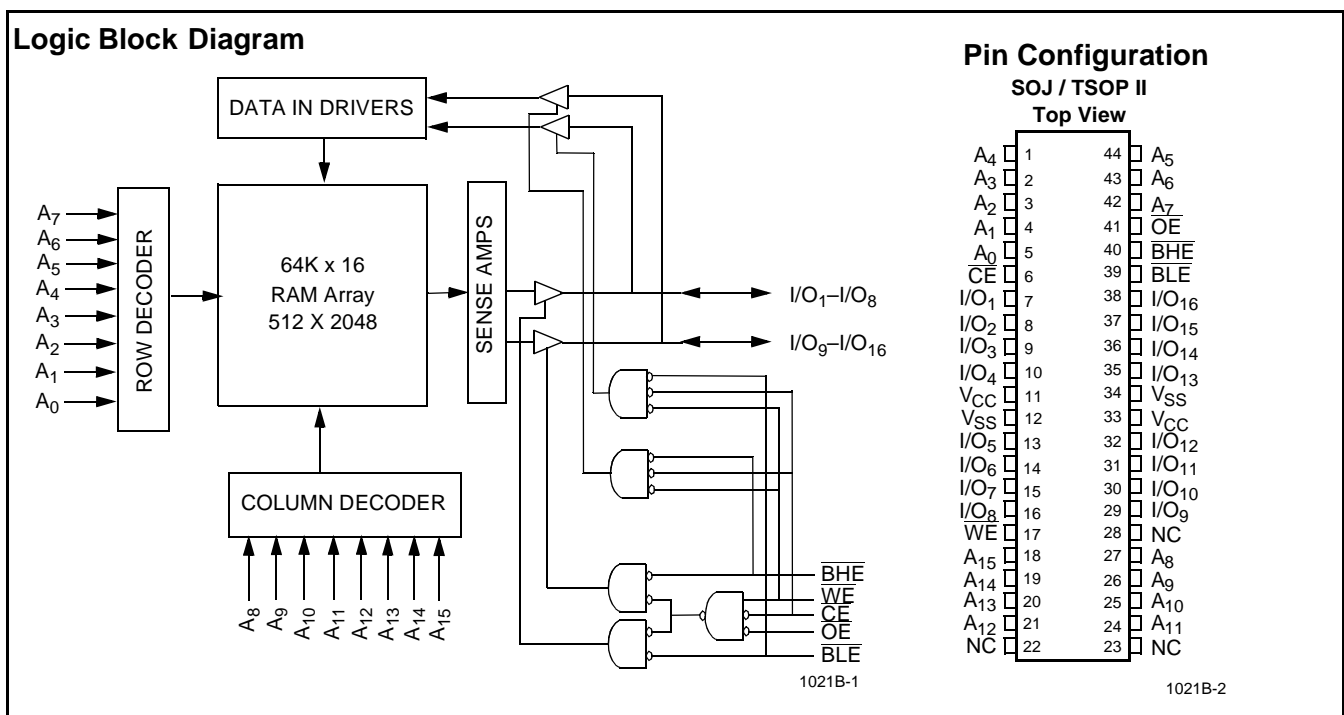
Writing to the device is accomplished by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. If Byte Low Enable

(\overline{BLE}) is LOW, then data from I/O pins (I/O_1 through I/O_8), is written into the location specified on the address pins (A_0 through A_{15}). If Byte High Enable (\overline{BHE}) is LOW, then data from I/O pins (I/O_9 through I/O_{16}) is written into the location specified on the address pins (A_0 through A_{15}).

Reading from the device is accomplished by taking Chip Enable (\overline{CE}) and Output Enable (\overline{OE}) LOW while forcing the Write Enable (\overline{WE}) HIGH. If Byte Low Enable (\overline{BLE}) is LOW, then data from the memory location specified by the address pins will appear on I/O_1 to I/O_8 . If Byte High Enable (\overline{BHE}) is LOW, then data from memory will appear on I/O_9 to I/O_{16} . See the truth table at the back of this data sheet for a complete description of read and write modes.

The input/output pins (I/O_1 through I/O_{16}) are placed in a high-impedance state when the device is deselected (\overline{CE} HIGH), the outputs are disabled (\overline{OE} HIGH), the \overline{BHE} and \overline{BLE} are disabled ($\overline{BHE}, \overline{BLE}$ HIGH), or during a write operation (\overline{CE} LOW, and \overline{WE} LOW).

The CY7C1021B is available in standard 44-pin TSOP Type II and 400-mil-wide SOJ packages.



Selection Guide

		7C1021B-9	7C1021B-10	7C1021B-12	7C1021B-15	7C1021B-20
Maximum Access Time (ns)	Commercial	9	10	12	15	20
Maximum Operating Current (mA)	Commercial	175	150	140	130	120
Maximum CMOS Standby Current (mA)	Commercial	10	10	10	10	10
	L	0.5	0.5	0.5	0.5	0.5

Shaded areas contain preliminary information.

Maximum Ratings

(Above which the useful life may be impaired. For user guidelines, not tested.)

Storage Temperature -65°C to +150°C

Ambient Temperature with

Power Applied -55°C to +125°C

Supply Voltage on V_{CC} to Relative GND^[1] -0.5V to +7.0V

DC Voltage Applied to Outputs

in High Z State^[1] -0.5V to $V_{CC}+0.5V$

DC Input Voltage^[1] -0.5V to $V_{CC}+0.5V$

Current into Outputs (LOW) 20 mA

Static Discharge Voltage >2001V
(per MIL-STD-883, Method 3015)

Latch-Up Current >200 mA

Operating Range

Range	Ambient Temperature ^[2]	V_{CC}
Commercial	0°C to +70°C	5V ± 10%
Industrial	-40°C to +85°C	5V ± 10%

Electrical Characteristics Over the Operating Range

Parameter	Description	Test Conditions	7C1021B-9		7C1021B-10		7C1021B-12		7C1021B-15		7C1021B-20		Unit
			Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
V_{OH}	Output HIGH Voltage	$V_{CC} = \text{Min.}$, $I_{OH} = -4.0 \text{ mA}$	2.4	2.4	2.4		2.4		2.4		2.4		V
V_{OL}	Output LOW Voltage	$V_{CC} = \text{Min.}$, $I_{OL} = 8.0 \text{ mA}$		0.4		0.4		0.4		0.4		0.4	V
V_{IH}	Input HIGH Voltage		2.2	6.0	2.2	6.0	2.2	6.0	2.2	6.0	2.2	6.0	V
V_{IL}	Input LOW Voltage ^[1]		-0.5	0.5	-0.5	0.8	-0.5	0.8	-0.5	0.8	-0.5	0.8	V
I_{IX}	Input Load Current	$GND \leq V_I \leq V_{CC}$	-1	+1	-1	+1	-1	+1	-1	+1	-1	+1	μA
I_{OZ}	Output Leakage Current	$GND \leq V_I \leq V_{CC}$, Output Disabled	-1	+1	-1	+1	-1	+1	-1	+1	-1	+1	μA
I_{OS}	Output Short Circuit Current ^[3]	$V_{CC} = \text{Max.}$, $V_{OUT} = GND$	-300			-300		-300		-300		-300	mA
I_{CC}	V_{CC} Operating Supply Current	$V_{CC} = \text{Max.}$, $I_{OUT} = 0 \text{ mA}$, $f = f_{MAX} = 1/t_{RC}$	175			150		140		130		120	mA
I_{SB1}	AutomaticCE Power-Down Current —TTL Inputs	Max. V_{CC} , $\overline{CE} \geq V_{IH}$, $V_{IN} \geq V_{IH}$ or $V_{IN} \leq V_{IL}$, $f = f_{MAX}$	40			40		40		40		40	mA
I_{SB2}	AutomaticCE Power-Down Current —CMOS Inputs	Max. V_{CC} , $\overline{CE} \geq$		10		10		10		10		10	mA
		$V_{CC} - 0.3V$, $V_{IN} \geq V_{CC} - 0.3V$, or $V_{IN} \leq 0.3V$, $f = 0$	L	0.5		0.5		0.5		0.5		0.5	mA

Shaded areas contain preliminary information.

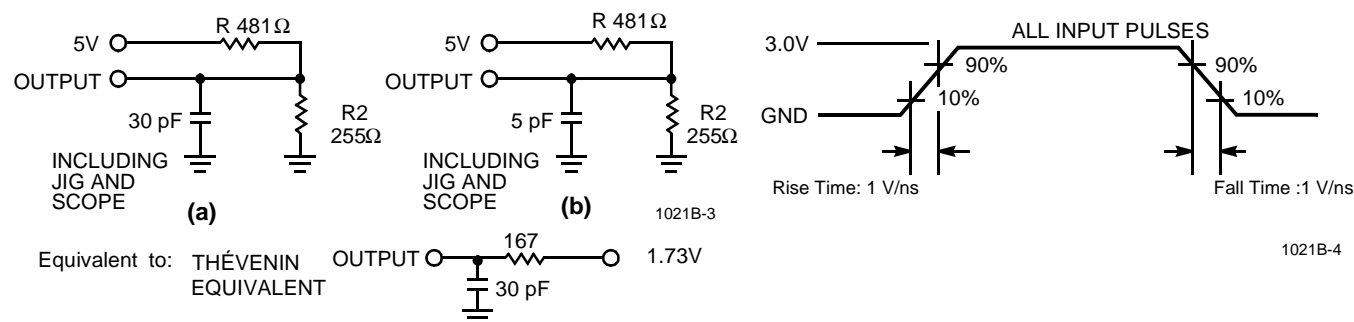
Capacitance^[4]

Parameter	Description	Test Conditions	Max.	Unit
C_{IN}	Input Capacitance	$T_A = 25^\circ\text{C}$, $f = 1 \text{ MHz}$, $V_{CC} = 5.0V$	8	pF
C_{OUT}	Output Capacitance		8	pF

Notes:

- $V_{IL}(\text{min.}) = -2.0V$ for pulse durations of less than 20 ns.
- T_A is the "Instant On" case temperature.
- Not more than one output should be shorted at one time. Duration of the short circuit should not exceed 30 seconds.
- Tested initially and after any design or process changes that may affect these parameters.

AC Test Loads and Waveforms



Switching Characteristics^[5] Over the Operating Range

Parameter	Description	7C1021B-9		7C1021B-10		7C1021B-12		7C1021B-15		7C1021B-20		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
READ CYCLE												
t _{RC}	Read Cycle Time	9		10		12		15		20		ns
t _{AA}	Address to Data Valid		9		10		12		15		20	ns
t _{OHA}	Data Hold from Address Change	3		3		3		3		3		ns
t _{ACE}	\overline{CE} LOW to Data Valid		9		10		12		15		20	ns
t _{DOE}	\overline{OE} LOW to Data Valid		5		5		6		7		9	ns
t _{LZOE}	\overline{OE} LOW to Low Z ^[6]	0		0		0		0		0		ns
t _{HZOE}	\overline{OE} HIGH to High Z ^[6, 7]		5		5		6		7		9	ns
t _{LZCE}	\overline{CE} LOW to Low Z ^[6]	3		3		3		3		3		ns
t _{HZCE}	\overline{CE} HIGH to High Z ^[6, 7]		5		5		6		7		9	ns
t _{PU}	\overline{CE} LOW to Power-Up	0		0		0		0		0		ns
t _{PD}	\overline{CE} HIGH to Power-Down		9		10		12		15		20	ns
t _{DBE}	Byte Enable to Data Valid		5		5		6		7		9	ns
t _{LZBE}	Byte Enable to Low Z	0		0		0		0		0		ns
t _{HZBE}	Byte Disable to High Z		5		5		6		7		9	ns
WRITE CYCLE ^[8]												
t _{WC}	Write Cycle Time	9		10		12		15		20		ns
t _{SCE}	\overline{CE} LOW to Write End	8		8		9		10		12		ns
t _{AW}	Address Set-Up to Write End	7		7		8		10		12		ns
t _{HA}	Address Hold from Write End	0		0		0		0		0		ns
t _{SA}	Address Set-Up to Write Start	0		0		0		0		0		ns
t _{PWE}	\overline{WE} Pulse Width	7		7		8		10		12		ns
t _{SD}	Data Set-Up to Write End	5		5		6		8		10		ns
t _{HD}	Data Hold from Write End	0		0		0		0		0		ns
t _{LZWE}	\overline{WE} HIGH to Low Z ^[6]	3		3		3		3		3		ns
t _{HZWE}	\overline{WE} LOW to High Z ^[6, 7]		5		5		6		7		9	ns
t _{BW}	Byte Enable to End of Write	7		7		8		9		12		ns

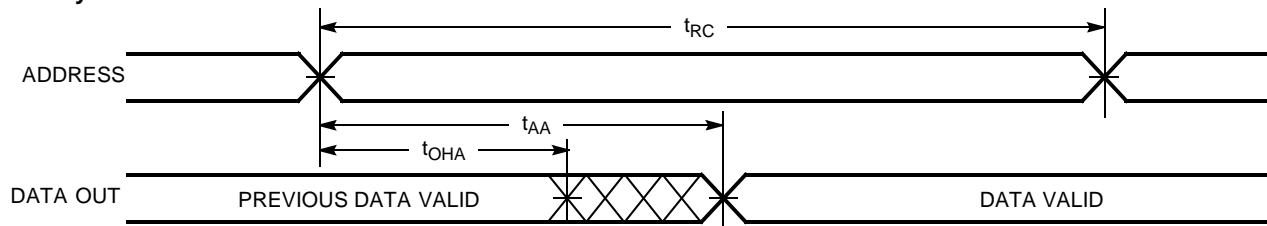
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Notes:

- Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V, and output loading of the specified I_{OL}/I_{OH} and 30-pF load capacitance.
- At any given temperature and voltage condition, t_{HZCE} is less than t_{LZCE} , t_{HZOE} is less than t_{LZOE} , and t_{HZWE} is less than t_{LZWE} for any given device.
- t_{HZOE} , t_{HZBE} , t_{HZCE} , and t_{HZWE} are specified with a load capacitance of 5 pF as in part (b) of AC Test Loads. Transition is measured ± 500 mV from steady-state voltage.
- The internal write time of the memory is defined by the overlap of \overline{CE} LOW, \overline{WE} LOW and \overline{BHE} / \overline{BLE} LOW. \overline{CE} , \overline{WE} and \overline{BHE} / \overline{BLE} must be LOW to initiate a write, and the transition of these signals can terminate the write. The input data set-up and hold timing should be referenced to the leading edge of the signal that terminates the write.

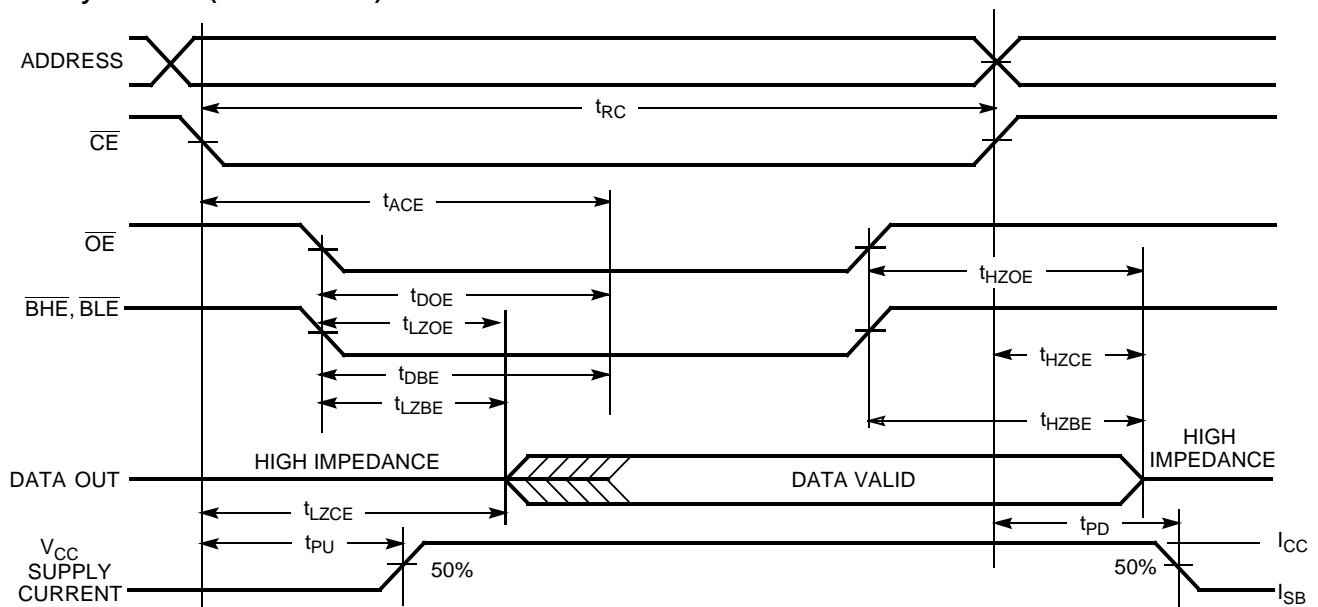
Switching Waveforms

Read Cycle No. 1^[9, 10]



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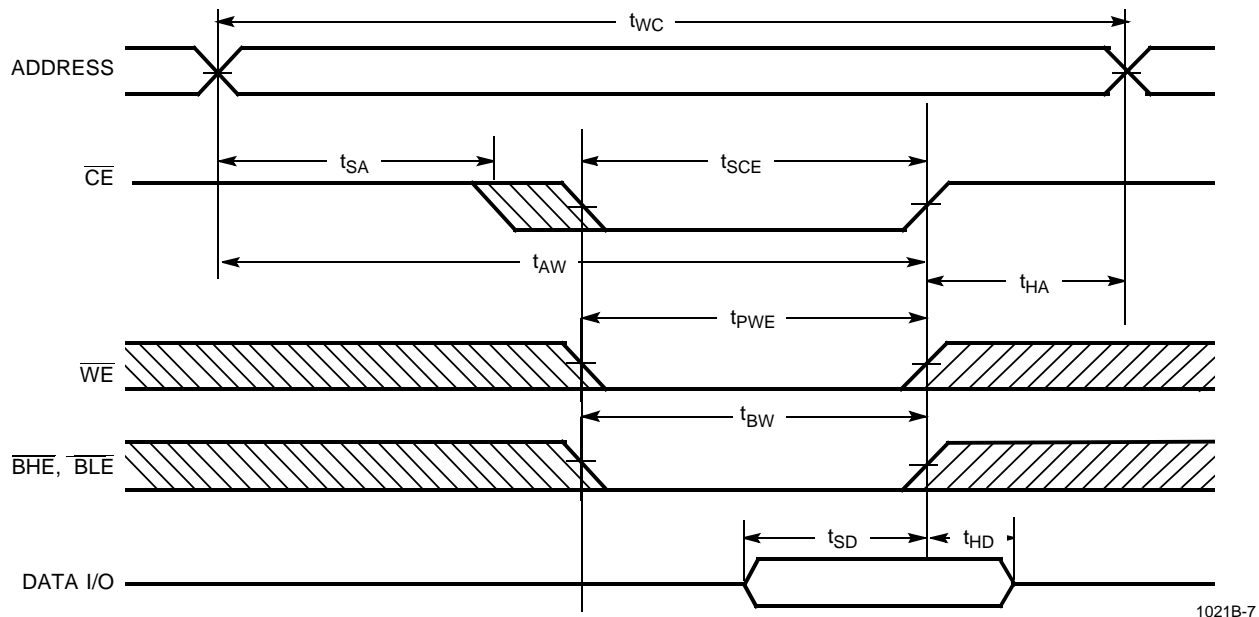
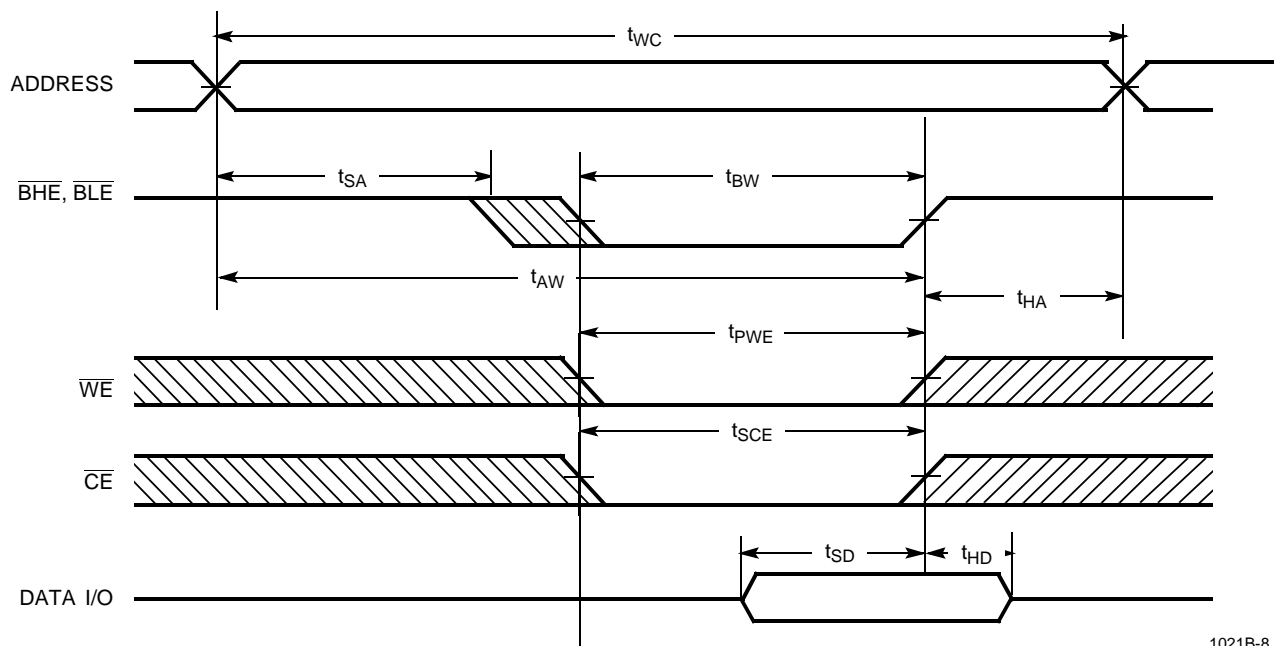
Read Cycle No. 2 (\overline{OE} Controlled)^[10, 11]



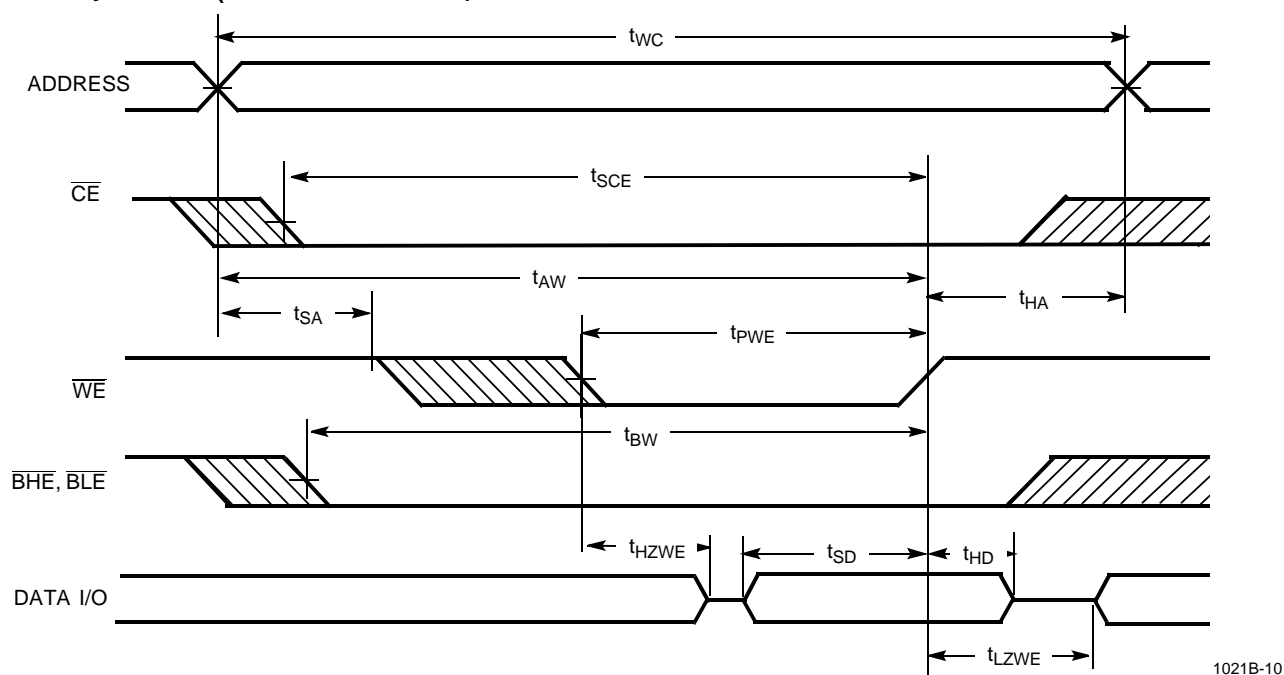
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Notes:

9. Device is continuously selected. \overline{OE} , \overline{CE} , \overline{BHE} and/or \overline{BLE} = V_{IL} .
10. \overline{WE} is HIGH for read cycle.
11. Address valid prior to or coincident with \overline{CE} transition LOW.

Switching Waveforms (continued)
Write Cycle No. 1 ($\overline{\text{CE}}$ Controlled) ^[12, 13]

Write Cycle No. 2 ($\overline{\text{BLE}}$ or $\overline{\text{BHE}}$ Controlled)

Notes:

12. Data I/O is high impedance if $\overline{\text{OE}}$ or $\overline{\text{BHE}}$ and/or $\overline{\text{BLE}} = V_{IH}$.
13. If $\overline{\text{CE}}$ goes HIGH simultaneously with $\overline{\text{WE}}$ going HIGH, the output remains in a high-impedance state.

Switching Waveforms (continued)
Write Cycle No. 3 (\overline{WE} Controlled, LOW)


1021B-10

Truth Table

\overline{CE}	\overline{OE}	\overline{WE}	\overline{BLE}	\overline{BHE}	I/O ₁ –I/O ₈	I/O ₉ –I/O ₁₆	Mode	Power
H	X	X	X	X	High Z	High Z	Power-Down	Standby (I_{SB})
L	L	H	L	L	Data Out	Data Out	Read - All bits	Active (I_{CC})
			L	H	Data Out	High Z	Read - Lower bits only	Active (I_{CC})
			H	L	High Z	Data Out	Read - Upper bits only	Active (I_{CC})
L	X	L	L	L	Data In	Data In	Write - All bits	Active (I_{CC})
			L	H	Data In	High Z	Write - Lower bits only	Active (I_{CC})
			H	L	High Z	Data In	Write - Upper bits only	Active (I_{CC})
L	H	H	X	X	High Z	High Z	Selected, Outputs Disabled	Active (I_{CC})
L	X	X	H	H	High Z	High Z	Selected, Outputs Disabled	Active (I_{CC})

Ordering Information

Speed (ns)	Ordering Code	Package Name	Package Type	Operating Range
10	CY7C1021B-10VC	V34	44-Lead (400-Mil) Molded SOJ	Commercial
	CY7C1021B-10ZC	Z44	44-Lead TSOP Type II	Commercial
	CY7C1021BL-10ZC	Z44	44-Lead TSOP Type II	Commercial
12	CY7C1021B-12VC	V34	44-Lead (400-Mil) Molded SOJ	Commercial
	CY7C1021B-12VI	V34	44-Lead (400-Mil) Molded SOJ	Industrial
	CY7C1021B-12ZC	Z44	44-Lead TSOP Type II	Commercial
15	CY7C1021B-15VC	V34	44-Lead (400-Mil) Molded SOJ	Commercial
	CY7C1021B-15VI	V34	44-Lead (400-Mil) Molded SOJ	Industrial
	CY7C1021B-15ZC	Z44	44-Lead TSOP Type II	Commercial
	CY7C1021B-15ZI	Z44	44-Lead TSOP Type II	Industrial
	CY7C1021BL-15ZC	Z44	44-Lead TSOP Type II	Commercial
20	CY7C1021B-20VC	V34	44-Lead (400-Mil) Molded SOJ	Commercial
	CY7C1021B-20ZC	Z44	44-Lead TSOP Type II	Commercial

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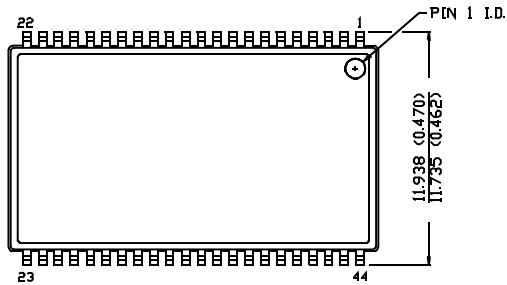
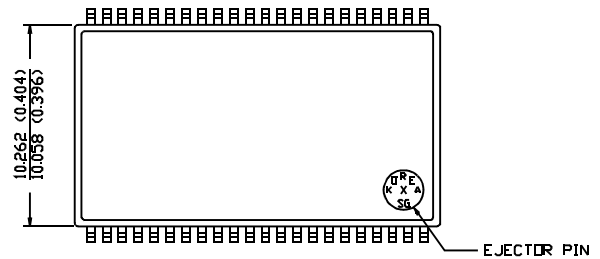
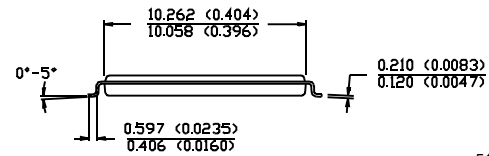
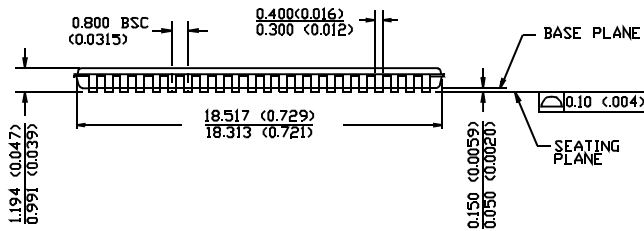


44-Lead (400-Mil) Molded SOJ V34



Package Diagrams (continued)

44-Pin TSOP II Z44

 DIMENSION IN MM (INCH)
 MAX
 MIN

TOP VIEW

BOTTOM VIEW


51-85087-A